

## **Multi-Layer Ceramic Capacitor**

C-S1-5-00

## C0G (NP0) Dielectrics

#### ■ Features

- A monolithic structure ensures high reliability and mechanical strength.
- High capacitance density.
- A wide range of capacitance values in standard case size.
- Suitable for high speed SMT placement on PCBs.
- Ni barrier termination highly resistance to migration.
- Lead-free termination is in compliance with the requirement of green plan and ROHS.

#### Applications

- General electronic equipment.
- Custom Application

#### ■ C0G (NP0) Dielectric Characteristics

Capacitance Range	0.20pF to 39nF								
Size (mm)	0603 1005 1608 2012 3216								
(EIA inch)	(0201) (0402) (0603) (0805) (1206)								
Test Voltage	1.0 ± 0.2Vrms								
Test Frequency	$1.0 \pm 0.2$ MHz for cap $\leq 1,000$ pF, $1.0 \pm 0.2$ KHz for cap $> 1,000$ pF								
Capacitance Tolerance	± 0.25pF, ± 0.50pF for cap < 5pF (± 0.1pF available on request)								
	± 0.50pF for 5pF≦cap<10pF (± 0.1pF, ± 0.25pF available on request)								
	± 5%, ± 10% for cap≧ 10pF (± 1%, ± 2% available on request)								
Operating Temperature Range	-55°C to +125°C								
Maximum Capacitance Change	0 ± 30 ppm/°C (EIA C0G)								
Rated Voltage	16, 25, 50, 100 VDC								
Dissipation Factor (DF)	1/(400 + 20 x C) for cap≤30pF, C in pF ; 0.1% max. for cap>30pF								
Insulation Resistance (+25°C, RVDC)	10,000 M $\Omega$ min. or 500 $\Omega$ -F min., whichever is smaller								
Insulation Resistance (+125℃, RVDC)	1,000 M $\Omega$ min. or 50 $\Omega$ -F min., whichever is smaller								



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### ■ Product Range and Thickness

CLASS																		
TYPE	Standard COG (NP0)																	
T.C SIZE	*0603	*0603 1005 1608 2012 3216																
(EIA)	0201		0402					603				305			1206			
RV	25V	16V	25V	50V	100V	16V	25V	50V	100V	16V	25V	50V	100	V	16V	25V	50V	100V
0.20 p		В	В	В	_	D	D	D	_					_	_	_	_	_
0.50 p	A A	B B	B B	B B	B B	D D	D D	D	D D	С	C	C	C	E	E	E	E	E
1.0 p	A	В	В	В	В	D	D	D	D	С	С	С	С	E	E	E	E	E
1.0 p	A	В	В	В	В	D	D	D	D	C	C	C	С	E	E	E	E	E
1.5 p	Α	В	В	В	В	D	D	D	D	С	С	С	С	Е	E	E	E	E
1.8 p	Α	В	В	В	В	D	D	D	D	С	С	С	С	E	E	E	E	E
2.2 p 2.7 p	A A	B B	B B	B B	B B	D D	D D	D D	D D	C	C	C	C	E	E E	E E	E	E E
3.3 p	A	В	В	В	В	D	D	D	D	С	С	С	С	E	E	E	E	E
3.9 p	Α	В	В	В	В	D	D	D	D	С	С	С	С	E	E	E	E	E
4.7 p	Α	В	В	В	В	D	D	D	D	С	С	С	С	Е	Е	Е	Е	Е
5.6 p	A	В	В	В	В	D	D	D	D	С	С	С	С	E	E	E	E	E
6.8 p 8.2 p	A A	B B	B B	B B	B B	D D	D D	D D	D D	C	C	C	C	E	E E	E E	E	E E
10 p	A	В	В	В	В	D	D	D	D	С	С	С	С	E	E	E	E	E
12 p	A	В	В	В	В	D	D	D	D	С	С	С	С	E	E	E	E	E
15 p	Α	В	В	В	В	D	D	D	D	С	С	С	С	Е	Е	Е	Е	Е
18 p	A	В	В	В	В	D	D	D	D	С	С	С	С	Ε	E	E	E	E
22 p 27 p	A A	B B	B B	B B	B B	D D	D D	D D	D D	С	C	C	C	E	E E	E E	E	E E
33 p	A	В	В	В	В	D	D	D	D	С	С	С	С	E	E	E	E	E
39 p	Α	В	В	В	В	D	D	D	D	С	С	С	С	E	E	E	E	E
47 p	Α	В	В	В	В	D	D	D	D	С	С	С	С	Е	Е	E	Е	Е
56 p	A	В	В	В	В	D	D	D	D	С	С	С	С	Е	E	E	E	E
68 p 82 p	A A	B B	B B	B B	B B	D D	D D	D D	D D	C	C	C	С	E	E E	E E	E	E E
100 p	Α	В	В	В	В	D	D	D	D	С	С	С	С	E	E	E	E	E
120 p		В	В	В	В	D	D	D	D	С	С	С	С	Е	E	E	E	E
150 p		В	В	В		D	D	D	D	С	С	С	С	Е	Е	Е	Е	Е
180 p		В	В	В		D D	D	D	D	С	С	С	С	Е	E	E	E	E
220 p 270 p		B B	B B	B B		D	D D	D D	D D	С	C	C	C	E	E E	E	E	E E
330 p		В	В	В		D	D	D	D	С	С	С	С	E	E	E	E	E
390 p		В	В	В		D	D	D	D	С	С	С	Е		Е	E	Е	Е
470 p		В	В	В		D	D	D	D	С	С	С	E		E	E	E	E
560 p 680 p						D D	D D	D D	D	C	C	C	E		E E	E E	E E	E E
820 p						D	D	D		С	C	C	E		E	E	E	E
1.0 n						D	D	D		С	С	С	Е	_	Е	E	Е	Е
1.2 n						D	D	D		Е	Е	Е	Е		Е	Е	Е	E
1.5 n						D	D	D		E	E	E	E		E	E	E	E
1.8 n 2.2 n						D D				E E	E	E E	E	_	E E	E E	E	E E
2.7 n						D				E G	E G	E G	G		E	E	E	E
3.3 n						D				E G	E G	E G	G		E	Е	Е	Е
3.9 n										G	G	G			E	E	E	E
4.7 n										G	G	G			E	E	E	Е
5.6 n 6.8 n										G G	G	G G			I F	I F	I F	
8.2 n										G	G	G			I F	I F	I F	
10 n										G	G	G			G	G	F L	
12 n										G					G			
15 n 18 n															G G			
22 n															G			
27 n															G			
33 n															G			
39 n			L	L	uo to to		L				<u> </u>				L			

Note: Thickness might be changed due to technology improvement.



## **Multi-Layer Ceramic Capacitor**

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### **Taping Amount**

	Thickness		Amount per reel									
	Thickness		180	mm (7")	250	mm (10")	330	mm (13")				
Code	Spec	Size(EIA)	Paper	Embossed	Paper	Embossed	Paper	Embossed				
Α	0.30+/-0.03	0603 (0201)	15K									
В	0.50+/-0.05	1005 (0402)	10K				50K					
С	0.60+/-0.15	2012 (0805)	4K		10K		15K					
		3216 (1206)	4K		10K		15K					
D	0.80+/-0.10	1608 (0603)	4K		10K		15K					
D*	0.80+0.15/ -0.10	1608 (0603)	4K		10K		15K					
		2012 (0805)	4K		10K		15K					
E	0.85+/-0.15	3216 (1206)	4K		10K		15K					
_	0.001, 0.10	3225 (1210)		3K				10K				
		4532 (1812)		1K								
1	0.95+/-0.15	2012 (0805)		3K								
•	0.001, 0.10	3216(1206)		3K								
F	1.15+/-0.20	3216 (1206)		3K				10K				
•	111017 0120	4520 (1808)		3K								
	1.25 +/-0.20	2012 (0805)		2K/3K				10K				
		3216 (1206)		3K				10K				
G		3225 (1210)		3K								
		4520 (1808)		3K								
		4532 (1812)		1K				4016				
	4.05.00/00	2012 (0805)		2K/3K				10K				
<u>G</u>	1.25+0.3/-0.2	3216 (1206)		3K				10K				
		3225(1210)		3K								
	1.50+/-0.20	3225 (1210)		2K								
Н		4520 (1808)		2K								
		4532 (1812)		1K								
	1.60+/-0.20	3216 (1206)		2K								
L		3225 (1210)		2K								
		4520 (1808)		2K								
		4532 (1812)		1K								
	1.60+0.30/-0.20	3216 (1206)		2K								
<u>L</u>		3225 (1210)		2K								
_		4520 (1808)		2K								
		4532 (1812)		1K								
N		3216 (1206)		2K/3K								
	2.00+/-0.20	3225 (1210)		2K								
	_	4520 (1808)		1K								
N.I.	0.00./0.00	4532 (1812)		1K								
<u>N</u>	2.00+/-0.30	3225 (1210)		2K								
Р	2.50+/-0.20	3225 (1210)		500pcs/1K								
<u>P</u>	2.50+/-0.30	3225 (1210)		500pcs/1K								
R	3.20+/-0.20			500pcs								
<u>R</u>	3.20+/-0.30			500pcs								

 $<sup>\</sup>ensuremath{^{*:}}$  For some products, the thickness spec can be 0.8+0.15/-0.1mm.



## **Multi-Layer Ceramic Capacitor**

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### ■ C0G (NP0) Specifications

No.	Ite	m	Specification				Test Method					
1	Operating Temp	erature Range	-55°C to 125°C					-				
2	Rated Voltage		16VDC, 25VDC, 50VDC, 100VDC				٧		-	as the maximum d continuously to the		
3	Appearance		No defects or	abnormalities			١	sual inspection	on			
4	Dimensions		Within the sp	ecified dimensi	on.		ι	sing calipers				
5	Dielectric Stren	gth (Flash)	No defects or abnormalities.				r f	No failure shall be observed when 250% of the rated voltage is applied between the terminations for 1 to 5 seconds, the charge and discharge current is less than 50mA.				
6	Insulation Resis	stance ( I.R.)	Rated Voltage: <500V	To apply rated voltage.	.R. ≥10G R.C <sub>R</sub> ≥5009					Ill be measured with a e rated voltage at 25℃		
			Rated Voltage: ≥500V	To apply 500V.	(whichever					1 minute of charging.		
7	Capacitance		Within the sp	ecified tolerand	e.					e measured at 25°C at		
8	Dissipation Fac	tor ( D.F.)	If C>30pF, DF $\leq$ 0.1% If C $\leq$ 30pF, DF $\leq$ 1/(400+20C), C in pF					the frequency and voltage shown in the tables.    Item   C≤1,000pF   >1,000pF     Frequency   1.0±0.2MHz   1.0±0.2KHz     Voltage   1.0±0.2Vrms   1.0±0.2Vrms				
9	Capacitance Tel Characteristics	mperature	Capacitance change within 0±30ppm/°C under operating temperature range.					Temperature compensating type: The capacitance value at $25^{\circ}$ C and $85^{\circ}$ C shall be measured and calculated from the formula given below. T.C.= $(C_{85}-C_{25})/C_{25}^{*} \Delta T^{*}10^{6}(PPM/^{\circ}C)$				
10	Termination Str	ength	No removal of the terminations or marking defect.					Apply a parallel force of 5N to a PCB mounted sample for 10±1sec. *2N for 0603 (EIA 0201).				
11	Deflection (Ben	ding Strength)	Appearance: No cracking or marking defects.  Capacitance change: within ±5% or ± 0.5pF. (whichever is larger)  Solder to boards)  Then again the solution and shall solder in the solution and shall solve the solution and shall so					older the capacitor to the test jig (glass epoxy oards) shown in Fig. a. using a eutectic solder. hen apply a force in the direction shown in Fig. b. he soldering shall be done with the reflow method nd shall be conducted with care so that the oldering is uniform and free of defects such as eat shock.				
			(Unit in mm) b c c c c c c c c c c c c c c c c c c	40 40 for 0603&1005 size	Size 0603 1005 1608 2012 ) 3216	a 0.3 0.4 1.0 1.2 2.2	b 0.9 1.5 3.0 4.0 5.0	C 0.3 0.5 1.2 1.65 2.0	I/—la	essurizing speed : 1.0mm/sec.		
12	Solderability of	Termination	90% of the termination is to be soldered evenly and continuously.				t	ontaining rosir 180℃ for 2 t	n for 3 to 5 sec to 3 minutes a	to a methanol solution conds, preheat it 150 nd immerse it into or 5±1seconds.		
13	la	Appearance	No marking d							to 150°C for 1 minute.		
	Soldering Heat	Cap. Change		P0 within ±2.5% or ±0.25pF. (whichever is				Immerse the capacitor in an eutectic solder solution at 270±5°C for 10±1 seconds. Let sit at room				
		D.F.		) 30pF, DF≦0.1% 30pF, DF≦1/(400+20C), C in p		ρF		temperature for 24±2 hours, then measure.  * Preheat at 150 to 200°ℂ for size≧3216				
		I.R.	I.R. $\geq$ 10,000MΩ or R <sub>i</sub> C <sub>R</sub> $\geq$ 500Ω-F. ( whichever is smaller)									



## **Multi-Layer Ceramic Capacitor**

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#### Continued from previous page.

14	Temperature Cycle (Thermal Shock)	Appearance	No marking defects	Solder the capacitor to supporting jig (glass epoxy board) and perform the five cycles according to the four heat treatments listed in the following table. Le sit for 24±2hrs at room temperature, then measure				
		Cap. Change	NP0 within ±2.5% or ±0.25pF. (whichever is larger)					
		D.F.	If C>30pF, DF $\leq$ 0.1% If C $\leq$ 30pF, DF $\leq$ 1/(400+20C), C in pF	Step 1: Minimum operating temperature 30±3min				
		I.R.	More than 10,000MΩ or $R_iC_R\!>\!500\Omega\text{-F}$ ( whichever is smaller )	Step 2: Room temperature 2~3 min Step 3: Maximum operating temperature 30±3min Step 4: Room temperature 2~3min				
15	Humidity Load	Appearance	No marking defects	Apply the rated voltage at 40±2℃ and 90 to 95%				
		Cap. Change	NP0 within ±7.5% or ±0.75pF. (whichever is larger)	humidity for 500±12 hours. Remove and let sit for 24±2 hours at room temperature, then measure. The charge/discharge current is less than 50mA.				
		D.F.	If C>30pF, DF $\leq$ 0.5% If C $\leq$ 30pF, DF $\leq$ 1/(100+10xC/3), C in pF	The charge/discharge current is less than 30mA.				
		I.R.	More than $500M\Omega$ or $R_iC_R \ge 25\Omega$ -F. (whichever is smaller)					
16	High Temperature	Appearance	No marking defects	Apply 200% of the rated voltage for 500±12 hours at the maximum operating temperature ± 3°C. Let				
	Load (Life Test)	Cap. Change	NP0 within ±7.5% or ±0.75pF (whichever is large)	sit for 24±2 hours at room temperature, then measure. The charge/discharge current is less than				
	(=	D.F.	If C>30pF, DF $\le$ 0.3% If 10pF< C $\le$ 30pF, DF $\le$ 1/(275+5xC/2) If C $\le$ 10pF, DF $\le$ 1/(200+10C), C in pF	50mA.				
		I.R.	More than 1 G $\Omega$ or R <sub>i</sub> C <sub>R</sub> $\geq$ 50 $\Omega$ -F. (whichever is smaller)					